



**BSI Standards Publication**

## **Surface chemical analysis — Depth profiling — Measurement of sputtered depth**

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## National foreword

This Published Document is the UK implementation of [ISO/TR 15969:2021](#). It supersedes [DD ISO/TR 15969:2001](#), which is withdrawn.

The UK participation in its preparation was entrusted to Technical Committee CII/60, Surface chemical analysis.

A list of organizations represented on this committee can be obtained on request to its committee manager.

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### Amendments/corrigenda issued since publication

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